R.N.G.P.I.T, Bardoli Electrical Engineering Department

Subject: Power Electronics

Prepared By: Dr. Shaikh Mohammed Suhel

Prepared By:

• NAME: DR. SHAIKH MOHAMMED SUHEL

(ASSISTANT PROFESSOR RNGPIT, SURAT)

- FORMER ASSISTANT PROFESSOR IN SCET, SNPIT&RC, VIT
- QUALIFICATION: PHD (POWER- ELECTRONICS & DRIVES, NIT, SURAT), M.TECH (INDUSTRIAL ELECTRONICS, NIT-SURAT), GATE, B.E. (ELECTRICAL ENGINEERING., VNSGU-SURAT).
- EXPERIENCE: 13 YEARS.

Power Electronics

• This Lecture contains

- Introduction & Turning On Methods for SCR
- Static VI characteristics of SCR
- Protection of SCR
- Firing circuit of SCR

• Syllabus:

1	Power switching devices	06
	Diode, Thyristor, MOSFET, IGBT; Static characteristics of these devices; Operation of	
	power devices as switches and switching losses, Single-quadrant switches, two-quadrant	
	and bidirectional switches; Firing circuit for thyristors; Gate drive circuits for MOSFET	
	and IGBT.	

Reference Books:

- M. H. Rashid, "Power electronics: circuits, devices, and applications", Pearson Education India, 2009.
- N. Mohan, T. M. Undeland, W.M. Robbins, "Power Electronics: Converters, Applications and Design", Wiley India Edition, 2007.
- R. W. Erickson and D. Maksimovic, "Fundamentals of Power Electronics", Springer Science & Business Media, 2007.
- 4. P.S. Bimbhra, "Power Electronics", Khanna Publishers, New Delhi, 2012..
- 5. L. Umanand, "Power Electronics: Essentials and Applications", Wiley India, 2009.

- Thyrsitor
- Combination THYRatron+transISTOR
- The definition of thyristor was given by IEC (International Electro technical Commission) in 1963 as
- (1) It consist of 3 or more pn junctions
- (2)Has two stable states (ON & OFF)
- Example:- SCR, Triac, diac, SCS (silicon controlled switch), PUT, GTO, RCT etc



- Silicon Controlled Rectifier (SCR) is made up of silicon and hence called SCR.
- It is unidirectional, Bipolar device
- SCR is widely used for high power (10kV,3000A, 30MW) applications.
- It is a 4 layer, 3 junction, PNPN semiconductor device



- Static I-V characteristics of SCR
- (1) Reverse blocking mode
- (2)Forward blocking Mode
- (3)Forward Conduction mode
- Reverse Blocking mode:
- $J_1 \& J_3$ are Reverse biased and J_2 is Forward biased
- Small reverse Leakage current (I_{RL}) of the order of few uA to mA flows.



- As Va increses barrier width of J₁ and J₃ increases. A point will reach where this junction will have avalanche break down at V_{BR} and hence la increses raidly=> heat increses=> temp=> and SCR may damage
- So applied voltage should be less than VBR to avoid damage of SCR.
- After breakdown of $J_1 \& J_3$ current is limited only by the load resistance



- Forward Blocking mode:
- J_1 and J_3 are forward biased and J_2 is reverse biased.
- So entire voltage will be drop across J_2
- Small forward leakage current (I_{FL}) will flows.
- As Va increases a point is reached where avalanche break down happens in J₂ and SCR starts conducting. This voltage is called V_{bo} (Forward break over voltage)



- (III)Forward conduction mode:
- As only J2 needs to be break down in this case
- *V_{Bo}<V_{BR}*
- After reachingV_{Bo} thyristor turns ON & shifts from point M to N and then to a point any where between N & K.
- After breakdown voltage drop across SCR drops to a very less value and current is limited only by the load.
- After breakdown la increases=> heat increase=> temp increases=> SCR may damage
- This method is not used in practice



- Thyristor turn-on method:
- (1) Forward voltage triggering
- (2) Gate triggering
- (3)dV/dT triggering
- (4) Thermal triggering
- (5) Light triggering
- (1) Forward voltage triggering:
- Without applying gate pulse if voltage Va is increased \mathcal{J}_2 will breakdown at $V_{bo}\cdot$
- At forward breakover voltage the characteristics curve break over and shifts to its on-state position with breakover current I_{bo} to point N
- This method is never employed in practice as they may destroyed the device due to avalanche breakdown is huge temp produced \cdot
- As V_{BO}<V_{BR}
- V_{Bo} represents rating of SCR as applied voltage should be less than this
- SCR can now be turned off only by reducing the anode current bellows a certain value called holding current (I_h)



- (2) Thermal Triggering
- During forward blocking moode entire voltage appears across J_2 and small leakage current flows•
- If temp of J_2 increases=> no of (thermal) carriers increases=> IL increses=> losses increses=> temp increases=> no of carriers increases=> width of depletion region decreases=> II increses=> losses increases=> temp increses=> carrires increses
- This is cumulative process and finally reverse biased junction J₂ vanishes and SCR will turn On.
- This method is not used in practice



- (3) Gate triggering
- It is most usual method of firing the forward biased SCR.
- When a positive gate pulse is applied, a significant number of electrons from n2 layer crosses J3 as N2 is heavily doped as compared to P2.
- After crossing junction J3 these electrons diffuse through P2 Layer. The electrons are then swept across junction J2 into the n1 layer.
- The electrons in n1 layer reduce the positive space charge in the n1 side of J2 as a result barrier width (J2) decreases and breakdown happens at a lower voltage.
- Higher the gate current lower the forward break over voltage



- Once the breakdown happens Ig is not required to keep it on and device remains in ON state.
- Latching Current is the minimum value of anode current which must be attained during the turn On process to maintain conduction even when the GATE signal is removed.
- So, Gate pulse should have sufficient width so that la reaches to l_L otherwise thyristor will not turn ON.
- Once the thyristor Turns ON Gate loses its control
- Holding current (I_h) is defined as the minimum value of anode current below which thyristor will turn off from off state



- (4) dv/dt triggering:
- Due to space charge existing in the depletion region J_2 , it behaves as a capacitor.

$$i_c = \frac{dQ}{dt} = \frac{d}{dt} (C_j \cdot V_a)$$

$$i_{c} = C_{j} \frac{dV_{a}}{dt} + V_{a} \frac{dC_{j}}{dt}$$

 As the junction capacitor is nearly constant,, dc;/dt=0

$$i_c = C_j \frac{dV_a}{dt}$$
 $i_c \propto \frac{dV_a}{dt}$

• Ic can play the role of gate current and hence can turn on SCR



- (5) Light triggering
- A niche is made in the inner P-Layer
- When the niche is irradiated, free charge carriers (Pairs of holes and electros) are generated just like when gate signal is applied.
- A pulse of light of appropriate wave length is guided by optical fibers for irradiation
- Such a thyristor is called LASCR (Light Activated SCR)
- Light triggering Thyristor has an advantage of electrical isolation between power and control circuit.
- Widely used in HVDC transmission system



- Two Transistor model of SCR
- The regenerative or latching action due to positive feedback can be explained using a 2 transistor model of sCR
- SCR is equivalent to PNP & NPN transistor connected in regenerative or +ve feedback

 $I_c = \alpha I_E + I_{CB0}$

 $I_c = \beta I_B$

Cut-off=> $I_c = I_{CB0}$ Active=> $I_c = \alpha I_E + I_{CB0}$

Saturation $= I_c = I_F$



- Two Transistor model of SCR
- As $V_b^{\uparrow} => I_b^{\uparrow} => Barrier width \downarrow=> I_E^{\uparrow}$

 $I_c = \alpha I_E$

 $I_c = \beta I_B$

 If I_b increase gradually => barrier width decreases and alpha increases



- Two Transistor model of SCR $I_c = \alpha I_F + I_{CR0}$ $I_{c1} = \alpha_1 I_A + I_{CR01}$ $I_{c2} = \alpha_2 I_K + I_{CB02}$ $I_k = I_G + I_A \qquad \qquad I_A = I_{C1} + I_{h1}$ $I_{A} = \alpha_{1}I_{A} + I_{CB01} + \alpha_{2}I_{K} + I_{CB02}$ $I_{A} = \alpha_{1}I_{A} + I_{CB01} + \alpha_{2}(I_{C} + I_{A}) + I_{CB02}$ $I_{A} = \frac{\alpha_{2}I_{G} + I_{CB01} + I_{CB02}}{1 - (\alpha_{1} + \alpha_{2})}$
- If $(\alpha_1 + \alpha_2) = 0 => I_A = infinite => Thyristor act as a close switch$
- Current is limited by load only



- Two Transistor model of SCR
- When Ig is suddenly applied say O to 1mA:
- I_{E2} or $I_k \Rightarrow \alpha_2 \Rightarrow I_{c2} \Rightarrow I_b \Rightarrow I_{E7} \Rightarrow \alpha_1 \Rightarrow I_{c2}$
- α₁ varies with I_A=I_{ET}
- α₂ varies with I_K=I_A+I_G



- Switching characteristics of SCR:
- Time variation of current through & Voltage across the SCR with time during turn-on and turn-off process is given by dynamic or switching characteristics of SCR.
- (a)Switching characteristics during turnon:
- When a forward biased thyristor is turnon, thyristor takes some time to change from blocking state to final On state

 $t_{on} = \text{Delay time}(t_d) + \text{Rise time}(t_r) + \text{spread time}(t_p)$



- Switching characteristics of SCR:
- Delay time (td): It is measured from the instant gate current reaches 90% of la to the instant at which anode current reaches 0.11a
- Also defined as time during which anode voltage falls from Va to 0.9 Va
- Delay time may be reduced by applying high magnitude gate current and high forward voltage between anode and cathode.



- Switching characteristics of SCR:
- Rise time (tr): Anode current reaches from 0.11a to 0.9 la.
- Va drops from 0.9Va to 0.1Va
- Delay time may be reduced by applying high magnitude gate current and high forward voltage between anode and cathode.

-> tr ~ Ig ~ build up rate of Ig -> to mainly depends on the nature of anode uct -> to I for RL CIL to I for RC act



(iii) spread time (tp):ia - 0.9Ia to Ia Va -, 0.1Va to on-state voltage drop (1 to 1.5V) - During this time the conduction spreads over the entire cross-section of the cathole of scr - to depends on area of cathode & structure of the gale -> Ig is generally 3 to 5 times the minimum gate current to turn on SCR.

- Protection of SCR:
- (a) Over current Protection
- Varistor (Voltage dependent resistor)
- (b) Over current protection
- Circuit breaker=> overload protection
- Fast acting current limiting fuse=> Short circuit protection
- (c) Thermal protection
- Heat sinks (Aluminum)
- (d)dv/dt protection
- Snubber circuit
- di/dt protection
- Series inductor
- Gate protection:
- R_2 -> Over current protection
- ZD-> Over voltage protection
- C₁-> To bypass noise signals
- R_2 -> To bypass thermally generated leakage current across junction J_2 ; Improves thermal stability





- Protection of SCR:
- Over voltages are due to inductance of the line i·e·, V=L·di/dt when suddenly open circuited·
- By increasing the rising time of V, dv/dt can be decreased. This can be done by using a capacitor across SCR.
- When the SCR is turned on, capacitor will discharge through SCR at a faster rate (di/dt) and may spoil the thyristor.
- So a resistor is connected in series with capacitor to limit this current.





- Snubber design:
- If the voltage build up across capacitor is assumed zero at the time of connecting supply, then capacitor is short circuited.





- Firing circuit of SCR:
- Resistance and resistance capacitance firing circuit
- Simplest and economical
- Limited range of firing angle (0 to 90°)
- R1 is used to limit the gate current $I_{gm} \geq Vm/R_1$
- Resistance R should have such a value that maximum voltage drop across it does not exceed maximum permissible gate voltage.
- Firing angle is controlled using Resistance R₂.

R Triggering Circuit















- RC Triggering:
- The Limited range of firing angle by resistance firing circuit can be overcome by RC firing circuit·
- When capacitor is charges to gate threshold voltage V_{gt} thyristor will triggered and turned ON
- By varying the resistance R charging time of capacitor can be controlled and hence firing angle alpha can be varying.

RC Half Wave Circuit









 $V_{\rm T}$

ωt



 $V_{\rm T}$

ωt

UJT Relaxation Oscillator











THANK YOU